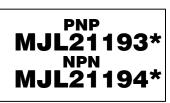


The MJL21193 and MJL21194 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

- Total Harmonic Distortion Characterized
- High DC Current Gain –

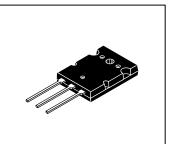
 $h_{FE} = 25 \text{ Min } @ \text{ IC} \\ = 8 \text{ Adc}$ 

- Excellent Gain Linearity
- High SOA: 2.25 A, 80 V, 1 Second



\*ON Semiconductor Preferred Device

16 AMPERE COMPLEMENTARY SILICON POWER TRANSISTORS 250 VOLTS 200 WATTS



#### CASE 340G-02 TO-3PBL

## MAXIMUM RATINGS

Rating	Symb ol	Value	Unit
Collector–Emitter Voltage	VCEO	250	Vdc
Collector-Base Voltage	VCBO	400	Vdc
Emitter–Base Voltage	V <sub>EBO</sub>	5	Vdc
Collector–Emitter Voltage – 1.5 V	VCEX	400	Vdc
Collector Current — Continuous Peak (1)	IC	16 30	Adc
Base Current – Continuous	ΙB	5	Adc
Total Power Dissipation @ T <sub>C</sub> = 25°C Derate Above 25°C	PD	200 1.43	Watts W/°C
Operating and Storage Junction Temperature Range	Тј, T <sub>stg</sub>	-65 to +150	°C

## THERMAL CHARACTERISTICS

Characteristic	Sym- bol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.7	°C/W

**ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS					
Collector–Emitter Sustaining Voltage (I <sub>C</sub> = 100 mAdc, I <sub>B</sub> = 0)	VCEO(sus)	250	—	_	Vdc
Collector Cutoff Current ( $V_{CE} = 200 \text{ Vdc}, I_B = 0$ )	ICEO	_	—	100	μAdc

(1) Pulse Test: Pulse Width = 5.0  $\mu$ s, Duty Cycle  $\leq$ 10%.

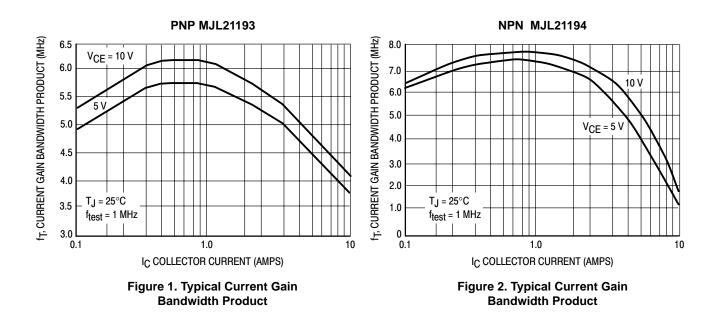
(continued)

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

## **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub> = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS		•				
Emitter Cutoff Current ( $V_{CE} = 5 \text{ Vdc}, I_{C} = 0$ )		IEBO	_	—	100	μAdc
Collector Cutoff Current (V <sub>CE</sub> = 250 Vdc, V <sub>BE(off)</sub> = 1.5 Vdc)		ICEX	_	—	100	μAdc
SECOND BREAKDOWN						
Second Breakdown Collector Current with Base Forward Biased (V <sub>CE</sub> = 50 Vdc, t = 1 s (non–repetitive) (V <sub>CE</sub> = 80 Vdc, t = 1 s (non–repetitive)		I <sub>S/b</sub>	4.0 2.25			Adc
ON CHARACTERISTICS						
DC Current Gain $(I_C = 8 \text{ Adc}, V_{CE} = 5 \text{ Vdc})$ $(I_C = 16 \text{ Adc}, I_B = 5 \text{ Adc})$		hFE	25 8		75 —	
Base–Emitter On Voltage (I <sub>C</sub> = 8 Adc, V <sub>CE</sub> = 5 Vdc)		V <sub>BE(on)</sub>	_	—	2.2	Vdc
Collector–Emitter Saturation Voltage $(I_C = 8 \text{ Adc}, I_B = 0.8 \text{ Adc})$ $(I_C = 16 \text{ Adc}, I_B = 3.2 \text{ Adc})$		VCE(sat)	_		1.4 4	Vdc
DYNAMIC CHARACTERISTICS						
Total Harmonic Distortion at the Output V <sub>RMS</sub> = 28.3 V, f = 1 kHz, P <sub>LOAD</sub> = 100 W <sub>RMS</sub>	hFE unmatched	T <sub>HD</sub>		0.8		%
(Matched pair h <sub>FE</sub> = 50 @ 5 A/5 V)	hFE matched		_	0.8 0.08		
Current Gain Bandwidth Product (I <sub>C</sub> = 1 Adc, V <sub>CE</sub> = 10 Vdc, f <sub>test</sub> = 1 MHz)		fT	4	—	—	MHz
Output Capacitance (V <sub>CB</sub> = 10 Vdc, I <sub>E</sub> = 0, f <sub>test</sub> = 1 MHz)		C <sub>ob</sub>	_	—	500	pF

(1) Pulse Test: Pulse Width =  $300 \ \mu$ s, Duty Cycle  $\leq 2\%$ 



## **TYPICAL CHARACTERISTICS**

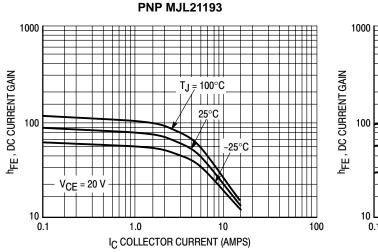
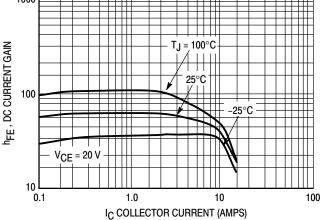


Figure 3. DC Current Gain, V<sub>CE</sub> = 20 V



NPN MJL21194

Figure 4. DC Current Gain, V<sub>CE</sub> = 20 V

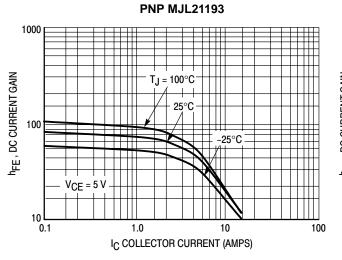


Figure 5. DC Current Gain, VCE = 5 V



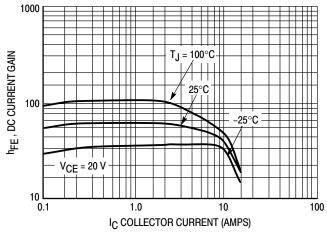
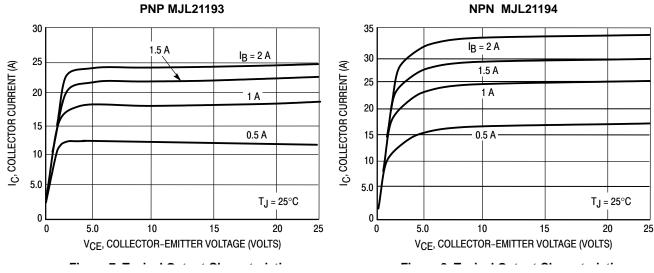


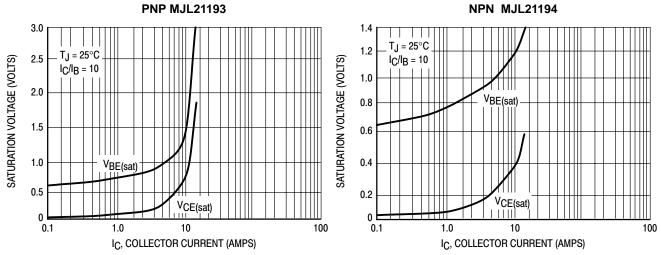
Figure 6. DC Current Gain, VCE = 5 V



PNP MJL21193

http://onsemi.com

### **TYPICAL CHARACTERISTICS**







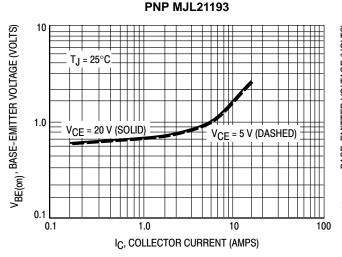
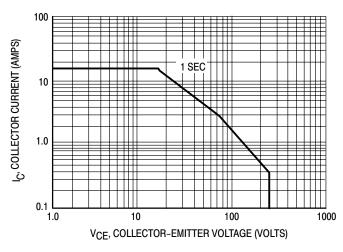
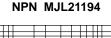


Figure 11. Typical Base–Emitter Voltage







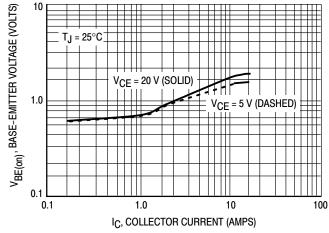


Figure 12. Typical Base–Emitter Voltage

There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate  $I_C - V_{CE}$  limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on  $T_{J(pk)} = 150^{\circ}$ C; T<sub>C</sub> is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

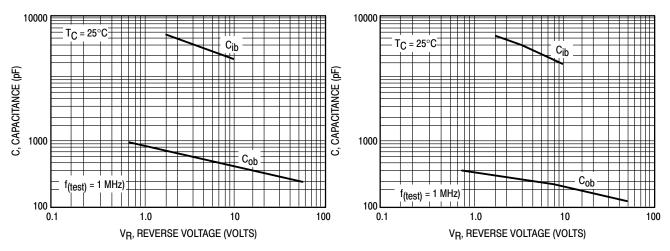


Figure 14. MJL21193 Typical Capacitance

Figure 15. MJL21194 Typical Capacitance

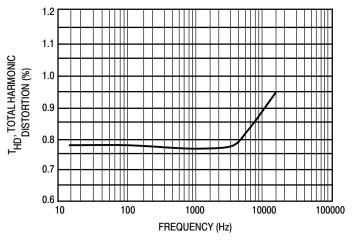


Figure 16. Typical Total Harmonic Distortion

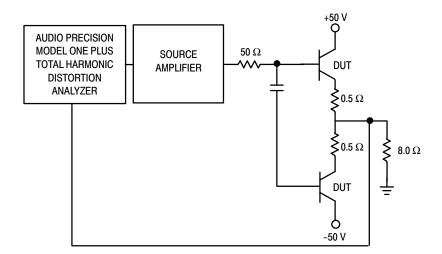
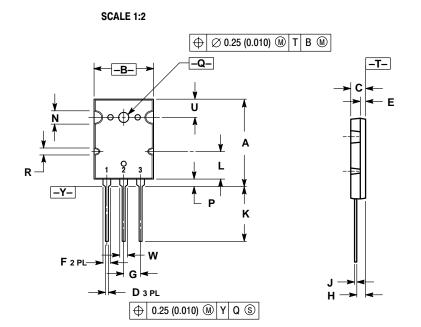


Figure 17. Total Harmonic Distortion Test Circuit

## PACKAGE DIMENSIONS

TO-3PBL (TO-264) CASE 340G-02 **ISSUE H** 



NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2 CONTROLLING DIMENSION: MILLIMETER.

2.	CONTROLLING DIMENSION: MILLIMETE

	MILLIMETERS		INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	28.0	29.0	1.102	1.142	
В	19.3	20.3	0.760	0.800	
С	4.7	5.3	0.185	0.209	
D	0.93	1.48	0.037	0.058	
Е	1.9	2.1	0.075	0.083	
F	2.2	2.4	0.087	0.102	
G	5.45 BSC		0.215 BSC		
н	2.6	3.0	0.102	0.118	
J	0.43	0.78	0.017	0.031	
K	17.6	18.8	0.693	0.740	
L	11.0	11.4	0.433	0.449	
Ν	3.95	4.75	0.156	0.187	
Ρ	2.2	2.6	0.087	0.102	
Q	3.1	3.5	0.122	0.137	
R	2.15	2.35	0.085	0.093	
U	6.1	6.5	0.240	0.256	
W	2.8	3.2	0.110	0.125	

# <u>Notes</u>

**ON Semiconductor** and without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer.

#### PUBLICATION ORDERING INFORMATION

#### Literature Fulfillment:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada

Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: ONlit@hibbertco.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

JAPAN: ON Semiconductor, Japan Customer Focus Center 4–32–1 Nishi–Gotanda, Shinagawa–ku, Tokyo, Japan 141–0031 Phone: 81–3–5740–2700 Email: r14525@onsemi.com

ON Semiconductor Website: http://onsemi.com

For additional information, please contact your local Sales Representative.

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.